



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10820496</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>HSU ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	46	09/26/2006	HK
307	48	09/26/2006	HK
307	67	09/26/2006	HK
307	72	09/26/2006	HK
307	80	09/26/2006	HK
307	83	09/26/2006	HK
307	85	09/26/2006	HK
307	100	09/26/2006	HK
320	130	09/26/2006	HK
363	56.02	09/26/2006	HK

U.S. Patent and Trademark Office	Part of Paper No.: 20060926
----------------------------------	-----------------------------

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10820496	HSU ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
307/46,48,57,64,66,67,80,82,83,85,86 (consulted Robert DeBeradinis)	09/26/2006	HK
320/128,137 (consulted Pia Tibbits)	09/26/2006	HK
363/17,56.02,98,131,132 (consulted Bao Vu)	09/26/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	09/26/2006	HK
307/57,64,66,82,86,104; 320/128,137; 363/17,98,126,127,131,132 (cursory)	09/26/2006	HK
U.S. Patent and Trademark Office		Part of Paper No.: 20060926